

P-Channel 15 V (D-S) MOSFET

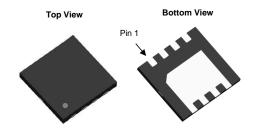
PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}$ (m Ω) (Max.)	I _D (A)	Q _g (Typ.)			
-15	4 at V _{GS} = - 4.5 V	- 60 ^a	6E ~C			
-10	5 at V _{GS} = - 2.5 V	- 52 ^a	65 nC			

FEATURES

- DT-Trench Power MOSFET
- Thermally Enhanced DFN3X3 Package
 - Small Footprint Area
 - Low On-Resistance

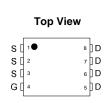


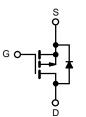
DFN 3x3



APPLICATIONS

· Load Switch, PA Switch, and Battery Switch for Portable





P-Channel MOSFET

ABSOLUTE MAXIMUM RATING	$S (T_A = 25 °C, unleady$	ess otherwise no	ted)		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage	V_{DS}	- 15	V		
Gate-Source Voltage		V_{GS}			± 8
Continuous Drain Current (T _J = 150 °C)	T _C = 25 °C		- 60 ^a		
	$T_C = 70 ^{\circ}\text{C}$ $T_A = 25 ^{\circ}\text{C}$	I _D	-49 ^a - 33 ^{b, c}	А	
	T _A = 70 °C		- 23 ^{b, c}		
Pulsed Drain Current (t = 300 μs)		I _{DM}	- 240		
Continuous Source-Drain Diode Current	$T_C = 25 \degree C$ $T_A = 25 \degree C$	I _S	- 60 ^a -37 ^{b, c}		
Maximum Power Dissipation	T _C = 25 °C		83		
	$T_C = 70 ^{\circ}\text{C}$ $T_A = 25 ^{\circ}\text{C}$	P _D	53 6.2 ^{b, c}	W	
	T _A = 70 °C		3.9 ^{b, c}		
Operating Junction and Storage Temperature R	T _J , T _{stg}	- 55 to 150	°C		
Soldering Recommendations (Peak Temperatur		260	C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R _{thJA}	16	26	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	1.3	1.5		

Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- d. See solder profile The DFN3X3 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 80 °C/W.





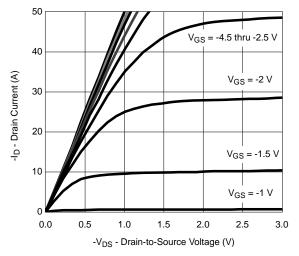
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 15			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	T _J I _D = - 250 μA		- 11		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	1 _D = - 250 μΑ		2.7		mv/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	- 0.5		- 1.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 12 V, V _{GS} = 0 V			- 1		
		V _{DS} = - 12 V, V _{GS} = 0 V, T _J = 55 °C		- 10		μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 60			Α	
Drain-Source On-State Resistance ^a		V _{GS} = - 4.5 V, I _D = - 30 A		4	5.2	mΩ	
	R _{DS(on)}	V _{GS} = - 2.5 V, I _D = - 20 A		5	6.5		
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 5 V, I _D = - 30 A		98		S	
Dynamic ^b							
Input Capacitance	C _{iss}			18825		pF	
Output Capacitance	C _{oss}	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		1540			
Reverse Transfer Capacitance	C _{rss}			623			
Total Gate Charge	Qg			65	90	nC	
Gate-Source Charge	Q_{gs}	$V_{DS} = -6 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -30 \text{ A}$		10			
Gate-Drain Charge	Q_{gd}			15			
Gate Resistance	R_g	f = 1 MHz		5		Ω	
Turn-On Delay Time	t _{d(on)}			25			
Rise Time	t _r	V_{DD} = - 6 V, R_L = 0.75 Ω		40		ns	
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ - 30 A, V_{GEN} = - 4.5 V, R_g = 1 Ω		63			
Fall Time	t _f			51			
Drain-Source Body Diode Characteristi	cs						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C	·		- 60	A	
Pulse Diode Forward Current	I _{SM}				240		
Body Diode Voltage	V_{SD}	$I_S = -8 \text{ A}, V_{GS} = 0 \text{ V}$		- 0.7	- 1.2	V	
Body Diode Reverse Recovery Time	Time t _{rr}			47	73	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 8 A, di/dt = 100 A/μs, T _{.I} = 25 °C		33		nC	
Reverse Recovery Fall Time	t _a	- 1 _F = 0 Λ, αναι = 100 Λνμο, 1 _J = 20 C		12		ns	
Reverse Recovery Rise Time	erse Recovery Rise Time t _b			29		115	

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

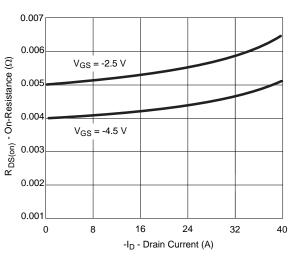
a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.



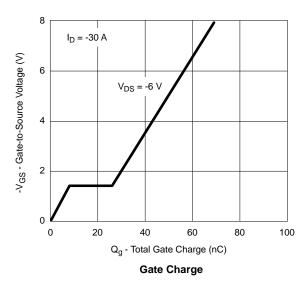
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

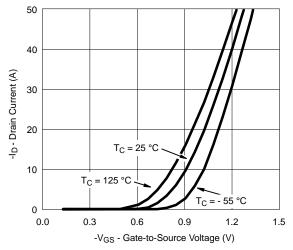


Output Characteristics

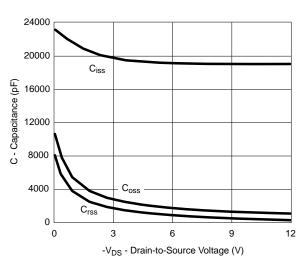


On-Resistance vs. Drain Current and Gate Voltage

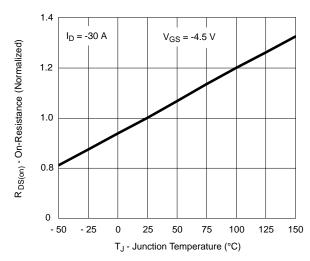




Transfer Characteristics



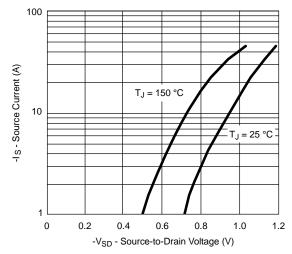
Capacitance



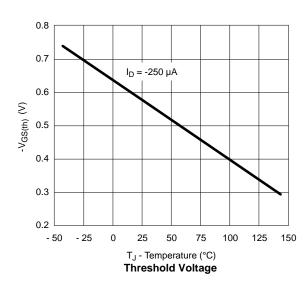
On-Resistance vs. Junction Temperature

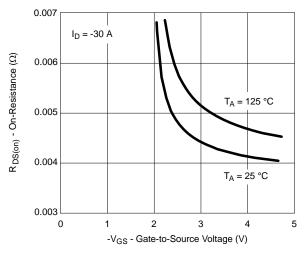


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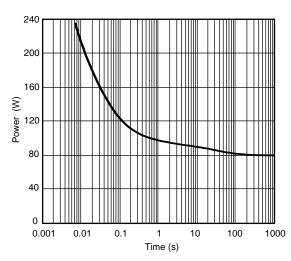


Soure-Drain Diode Forward Voltage

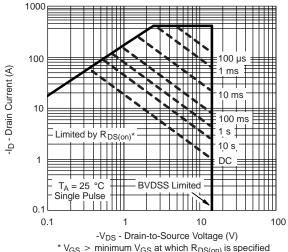




On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient



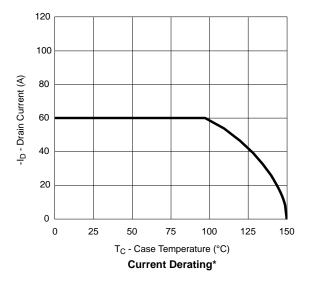
* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

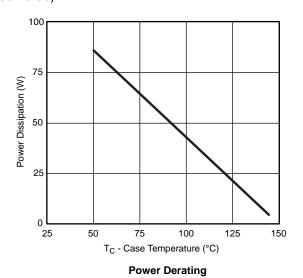
Safe Operating Area, Junction-to-Ambient





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





^{*} The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





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